

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/074,090	BARSZCZ, CHESTER J.	
Examiner		Art Unit		Page 1 of 1
Minh Dieu Nguyen		2137		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,856,913	02-2005	Silberstein, Richard B.	702/19
	B	US-6,550,011	04-2003	Sims, III, J Robert	713/193
	C	US-2002/0052562	05-2002	Lipman, Jonathon J.	600/557
	D	US-6,175,924	01-2001	Arnold, Todd Weston	713/189
	E	US-2002/0035486	03-2002	Huyn et al.	705/3
	F	US-5,991,731	11-1999	Colon et al.	705/3
	G	US-6,311,179	10-2001	Agarwal et al.	707/3
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.